Solution Selling 1977: Semiconductor Equipment Marketing Shifts from Selling Tools

Applied Materials has always had a reputation for recognizing customer needs early on. This AMAT ad from 1977 is one of the earliest examples of a marketing shift from selling products to selling solutions to specific application needs. This marketing revolution in the semiconductor equipment industry was brought by Bob Graham. It would turn out to be what would decades later be called 'blue ocean strategy.' At the time, competitors scoffed at this as being obvious, leaving the market position of being a solution provider open to Applied Materials for years. It also provided a new framework for innovation that would serve Applied for decades, as they began to search for specific application problems customers were having ... for which their equipment could be used to provide a unique solution.



PRODUCTION (1) One micron thick—continuous process.
(2) Five micron thick Epi;
2 runs per hour—single station. Model No. Station AMS-2000 AMI-6000 AMC-7600 AMC-7000 AMG-500 C AMP-9000 AMP-3300 Plasma AMS-1000 AMV-1200D AMV-800D Single Single

2 runs per hour—single station			Gtanori		Duai		Olligie		Olligio		Onigio.	Olligio	LI OTO		1 1001110		0.001				0001		_		_			- Cirigio		
3 runs per hour—dual stati (3) 5000 A (*)	A/Dep Process 5000 SiH ₄ 1000 SiH ₅ 1000 SiH ₂ Cl ₂ 5000 SiH ₂ Cl ₂		Configuration Heating	Continuous Resistance	Horizi R.	ontal F.	Cylinder Radiant		Cylinder Radiant		Cylinder R.F.	Cylinder R.F.	Tube Resistance		Vertical Resistance +R.F.		Vertical Resistance		Semi-Cout. Resistance		Vertical R.F.		Vertical R.F.		Semi-Cont. Resistance		Vertical R.F.		Vertical R.F.	
Polysiticon: 200 Silicon Nitride: 170			Wafer Size	3" 4*	3"	4"	3"	4"	3"	4"	Random	Random	3"	4"	3"	4"	3"	4"	3"	4"	3"	4"	3"	4"	3"	4*	31	4"	3"	4"
Silicon Dioxide: 70			Wafer Capacity/Station	Continuous	24	12	30	14	18	-	o in ₹/Run	60 in ² /Run	200	200	25	14	8	5	21	10	8	5	+	-	10	3	8	5	-	-
10°40' 03°4 103			Wafer Throughput/Hr.	160, 80,	722	362	60 ₂	282	362	-		RATE.	(*)	(*)	50,	28,	24,	151	84,	401	24,	15,	7	-	401	12,	162	102	1	-
	REACTANTS	AMBIENT	TEMP. (°C)	34							100				-							31							10	
EPITAXIAL SILICON -	Silane (SiH ₄)	H ₂	1000-1050	V 7 9				П	•				0									•		•	-			•	•	
	Dichlorosilane (SiH ₂ Cl ₂)	Hz	1050-1100		•				•											1	•	•		•		71		•		
	Trichlorosilane (SiHCl _a)	H ₂	1100-1150			•					7										•	•	1					•	•	
	Silicontetrachloride (SiCl ₄)	Н	1150-1200		•	,			•	Bon I	-		+								•	•						•	•	
WAFER ETCH/CLEAN	Hydrogen Chloride (HCL)	Ha	800-1200								•	•		•		1.1					•	•						•	•	K p
ALUMINA (Al ₂ O ₂)	Aluminum Trichloride with Carbon Dioxide (AICl ₃ - CO ₂)	H ₂	850-960													- 17					•	•	13	•				•	•	,
SILICON NITRIDE (SI ₂ N ₄)	Silane with Ammonia (SiH ₄ + NH ₈)	N ₂	25-400						30		-				•	•														
	Dichlorosilane with Ammonia (SiH ₂ Cl ₂ + NH ₃)	N ₂	750-900											•								U+-S	1		1		- 1			
	Silane with Ammonia (SiH ₄ + NH ₃)	N ₂ +	750-800				1				T.	**									•	•	1,3	•		Щ		•	•	
	Silane with Ammonia (SiH ₄ + NH ₃)	Ha	950-1000	7-11-1	•	•	•	-				1			2000	-						•		•	1	-		•	•	
POLYSILICON	Silane (SiH ₄)	N ₂	650-700							A				•								•		•				•	•	
	Silane (SiH ₄)	Ha	850-950							X.	To si				M		200				13.	•	10	•				•		,
SILICON DIOXIDE (SIO ₂)	Silane with Oxygen (SiH ₄ + O ₂)	N ₂	350-500	•										0			120	•				M	- 1			•	P.L			NE.
	Doped Oxides (SiH ₄ + O ₂ + Dopant)	N ₂	400-500			I S										N'	. 15	•		•			1		4	•				
	Silane with Nitrous Oxide (SiH ₄ + N ₂ O)	N ₂	750-850												1						•	•		•				•		
	Dichlorosilane with Nitrous Oxide (SiH ₂ Cl ₂ + N ₂ O)	N ₂	900-950	12										•							13		15				1		100	7
	Silane with Carbon Dioxide (SiH ₄ + CO ₂)	Ha	950-1000		•) i	1 6						-					•	TE	•			-	•	•	
	Gallium Arsenide Phosphide (Red)	H ₂	750-800								•																= 1			
	Gatlium Phosphide (Yellow or Green)	Hz	800-850									•									F		100					1 1		1
SPECIAL DEPOSITION																														
DUAL LAYER IN-SITU NITRIDE/OXIDE	Dichlorosilane with Ammonia (SiH ₂ Cl ₂ + NH ₃) Dishlorosilane with Nitrous Oxide (SiH-Cl ₂ + N-O)	Ne	850-950											•					11-	H					-					
	Silane with Ammonia (SiH ₄ + NH ₃) Silane with Carbon Dioxide	H ₂	950-1000								0	140-		y.								•		•) W		•	•	
SILICON ON SAPPHIRE	Silane	Hz	950-975			,																•	1	• .		-		•	•	
	3 rurs per Four—dust stat (3) 5000 A (7) Water-Ner. Polysiticon Visition Nitridis: 120 Silicon Nitridis: 120 Silicon Dicxide: 70 \$100-1000 Polysiticon Nitridis: 120 Silicon Nit	3 1 2 2 2 2 2 2 2 2 2	3 nurs per hour—cual station 13 stood 17 17 17 17 17 17 17 1	Configuration Configuratio	3 may per hour—dust station Configuration Fleating Configuration Configuration Fleating Configuration Fleating	Configuration Continuous Configuration Continuous Continuous Configuration Configuration Continuous Configuration Configu	Configuration Configuratio	Configuration Continuous Horizontal Horizontal	Silicon Protect Air Protect Protect	Same Prince Pri	Configuration Configuratio	Configuration Continuous Continuous	10 10 10 10 10 10 10 10	Single Post Post	Display of Nort — all station Property Property	Configuration Configuratio	10 10 10 10 10 10 10 10	Single Prince Prince	Continue Continue	Second Content of the Content of t	Continue High part High	Configuration Configuratio	Continue Continue	Configuration	Continuous Con	Configuration	Configuration Configuratio	Configuration - Continue of Part	Configuration Configuratio	Control Cont

No other company can make that statement.

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